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Kind regards,

Team Nexperia

# PHK04P02T

P-channel vertical D-MOS logic level FET

Rev. 02 — 14 December 2010

Product data sheet

## 1. Product profile

### 1.1 General description

Logic level P-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using vertical D-MOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

### 1.2 Features and benefits

- Suitable for high frequency applications due to fast switching characteristics
- Suitable for logic level gate drive sources
- Suitable for very low gate drive sources voltage

### 1.3 Applications

- Battery powered applications
- High-speed digital interfaces

### 1.4 Quick reference data

Table 1. Quick reference data

| Symbol                  | Parameter                        | Conditions                                                                                          | Min | Typ  | Max       | Unit |
|-------------------------|----------------------------------|-----------------------------------------------------------------------------------------------------|-----|------|-----------|------|
| V <sub>DS</sub>         | drain-source voltage             | T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 150 °C                                                     | -   | -    | -16       | V    |
| I <sub>D</sub>          | drain current                    | T <sub>sp</sub> = 25 °C                                                                             | -   | -    | -4.6<br>6 | A    |
| P <sub>tot</sub>        | total power dissipation          |                                                                                                     | -   | -    | 5         | W    |
| Static characteristics  |                                  |                                                                                                     |     |      |           |      |
| R <sub>DSon</sub>       | drain-source on-state resistance | V <sub>GS</sub> = -2.5 V; I <sub>D</sub> = -1 A; T <sub>j</sub> = 25 °C                             | -   | 117  | 150       | mΩ   |
|                         |                                  | V <sub>GS</sub> = -4.5 V; I <sub>D</sub> = -1 A; T <sub>j</sub> = 25 °C                             | -   | 80   | 120       | mΩ   |
| Dynamic characteristics |                                  |                                                                                                     |     |      |           |      |
| Q <sub>GD</sub>         | gate-drain charge                | V <sub>GS</sub> = -4.5 V; I <sub>D</sub> = -1 A;<br>V <sub>DS</sub> = -10 V; T <sub>j</sub> = 25 °C | -   | 1.83 | -         | nC   |



## 2. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description | Simplified outline   | Graphic symbol   |
|-----|--------|-------------|----------------------|------------------|
| 1   | S      | source      | <p>SOT96-1 (SO8)</p> | <p>001aaa025</p> |
| 2   | S      | source      |                      |                  |
| 3   | S      | source      |                      |                  |
| 4   | G      | gate        |                      |                  |
| 5   | D      | drain       |                      |                  |
| 6   | D      | drain       |                      |                  |
| 7   | D      | drain       |                      |                  |
| 8   | D      | drain       |                      |                  |

## 3. Ordering information

Table 3. Ordering information

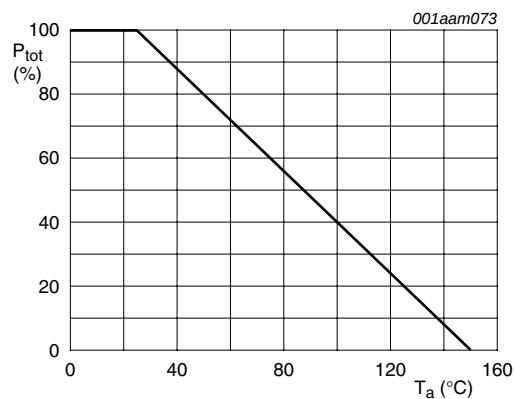
| Type number | Package |                                                           |         |
|-------------|---------|-----------------------------------------------------------|---------|
|             | Name    | Description                                               | Version |
| PHK04P02T   | SO8     | plastic small outline package; 8 leads; body width 3.9 mm | SOT96-1 |

## 4. Limiting values

Table 4. Limiting values

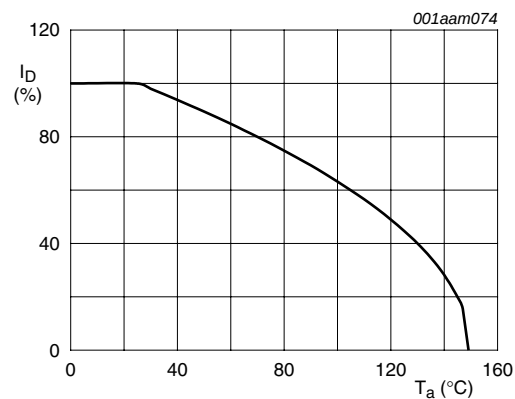
In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol                    | Parameter               | Conditions                                              | Min | Max   | Unit |
|---------------------------|-------------------------|---------------------------------------------------------|-----|-------|------|
| $V_{DS}$                  | drain-source voltage    | $T_j \geq 25\text{ °C}$ ; $T_j \leq 150\text{ °C}$      | -   | -16   | V    |
| $V_{DGR}$                 | drain-gate voltage      | $R_{GS} = 20\text{ k}\Omega$                            | -   | -16   | V    |
| $V_{GS}$                  | gate-source voltage     |                                                         | -8  | 8     | V    |
| $I_D$                     | drain current           | $T_{sp} = 100\text{ °C}$                                | -   | -1.87 | A    |
|                           |                         | $T_{sp} = 25\text{ °C}$                                 | -   | -4.66 | A    |
| $I_{DM}$                  | peak drain current      | $T_{sp} = 25\text{ °C}$ ; pulsed                        | -   | -26.4 | A    |
| $P_{tot}$                 | total power dissipation | $T_{sp} = 25\text{ °C}$                                 | -   | 5     | W    |
|                           |                         | $T_{sp} = 100\text{ °C}$                                | -   | 2     | W    |
| $T_{stg}$                 | storage temperature     |                                                         | -55 | 150   | °C   |
| $T_j$                     | junction temperature    |                                                         | -55 | 150   | °C   |
| <b>Source-drain diode</b> |                         |                                                         |     |       |      |
| $I_S$                     | source current          | $T_{sp} = 25\text{ °C}$                                 | -   | -4.66 | A    |
| $I_{SM}$                  | peak source current     | $T_{sp} = 25\text{ °C}$ ; pulsed; $t_p \leq 5\text{ s}$ | -   | -26   | A    |



$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

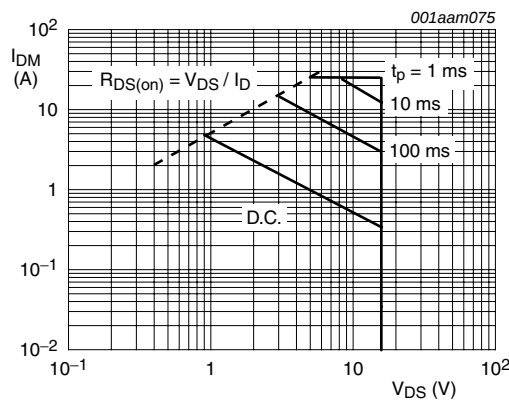
Fig 1. Normalised power dissipation as a function of ambient temperature



$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100\%$$

$$V_{GS} \leq -10\text{ V}$$

Fig 2. Normalized continuous drain current as a function of ambient temperature



$$T_{sp} = 25^{\circ}C; I_{DM} \text{ is single pulse}$$

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

5. Thermal characteristics

Table 5. Thermal characteristics

| Symbol         | Parameter                                        | Conditions                      | Min | Typ | Max | Unit |
|----------------|--------------------------------------------------|---------------------------------|-----|-----|-----|------|
| $R_{th(j-sp)}$ | thermal resistance from junction to solder point | mounted on metal clad substrate | -   | 25  | -   | K/W  |

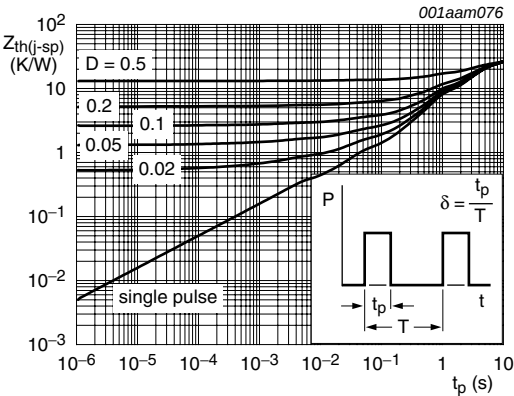
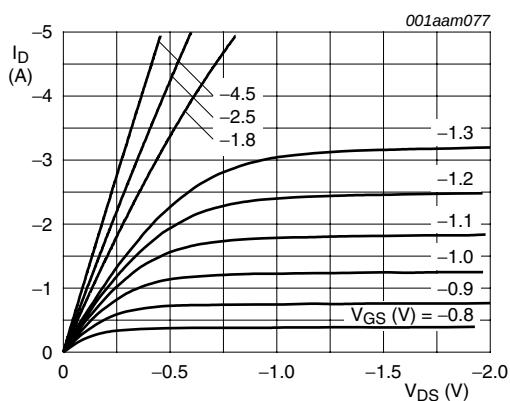


Fig 4. Transient thermal impedance from junction to solder point as a function of pulse duration

## 6. Characteristics

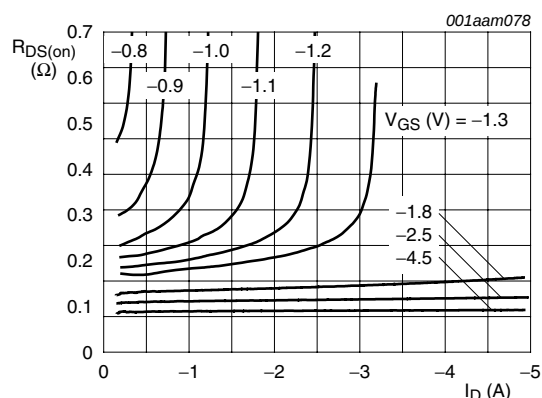
Table 6. Characteristics

| Symbol                  | Parameter                        | Conditions                                                                                                                                       | Min  | Typ   | Max  | Unit |
|-------------------------|----------------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------|------|-------|------|------|
| Static characteristics  |                                  |                                                                                                                                                  |      |       |      |      |
| V <sub>(BR)DSS</sub>    | drain-source breakdown voltage   | I <sub>D</sub> = -10 μA; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C                                                                           | -16  | -     | -    | V    |
| V <sub>GS(th)</sub>     | gate-source threshold voltage    | I <sub>D</sub> = -1 mA; V <sub>DS</sub> = V <sub>GS</sub> ; T <sub>j</sub> = 25 °C                                                               | -0.4 | -0.6  | -    | V    |
|                         |                                  | I <sub>D</sub> = -1 mA; V <sub>DS</sub> = V <sub>GS</sub> ; T <sub>j</sub> = 150 °C                                                              | -0.1 | -     | -    | V    |
| I <sub>DSS</sub>        | drain leakage current            | V <sub>DS</sub> = -13 V; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C                                                                           | -    | -50   | -100 | nA   |
|                         |                                  | V <sub>DS</sub> = -13 V; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 150 °C                                                                          | -    | -13   | -100 | μA   |
| I <sub>GSS</sub>        | gate leakage current             | V <sub>GS</sub> = 8 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C                                                                             | -    | 10    | 100  | nA   |
|                         |                                  | V <sub>GS</sub> = -8 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C                                                                            | -    | 10    | 100  | nA   |
| R <sub>DSon</sub>       | drain-source on-state resistance | V <sub>GS</sub> = -2.5 V; I <sub>D</sub> = -1 A; T <sub>j</sub> = 25 °C                                                                          | -    | 117   | 150  | mΩ   |
|                         |                                  | V <sub>GS</sub> = -2.5 V; I <sub>D</sub> = -1 A; T <sub>j</sub> = 150 °C                                                                         | -    | 175   | 230  | mΩ   |
|                         |                                  | V <sub>GS</sub> = -1.8 V; I <sub>D</sub> = -0.5 A; T <sub>j</sub> = 25 °C                                                                        | -    | 140   | 180  | mΩ   |
|                         |                                  | V <sub>GS</sub> = -4.5 V; I <sub>D</sub> = -1 A; T <sub>j</sub> = 25 °C                                                                          | -    | 80    | 120  | mΩ   |
| Dynamic characteristics |                                  |                                                                                                                                                  |      |       |      |      |
| Q <sub>G(tot)</sub>     | total gate charge                | I <sub>D</sub> = -1 A; V <sub>DS</sub> = -10 V; V <sub>GS</sub> = -4.5 V; T <sub>j</sub> = 25 °C                                                 | -    | 7.2   | -    | nC   |
| Q <sub>GS</sub>         | gate-source charge               |                                                                                                                                                  | -    | 1.7   | -    | nC   |
| Q <sub>GD</sub>         | gate-drain charge                |                                                                                                                                                  | -    | 1.83  | -    | nC   |
| C <sub>iss</sub>        | input capacitance                | V <sub>DS</sub> = -13 V; V <sub>GS</sub> = 0 V; f = 1 MHz; T <sub>j</sub> = 25 °C                                                                | -    | 528   | -    | pF   |
| C <sub>oss</sub>        | output capacitance               |                                                                                                                                                  | -    | 200   | -    | pF   |
| C <sub>rss</sub>        | reverse transfer capacitance     |                                                                                                                                                  | -    | 57    | -    | pF   |
| t <sub>d(on)</sub>      | turn-on delay time               | V <sub>DS</sub> = -10 V; R <sub>L</sub> = 10 Ω; V <sub>GS</sub> = -8 V; R <sub>G(ext)</sub> = 6 Ω; T <sub>j</sub> = 25 °C; I <sub>D</sub> = -1 A | -    | 2     | -    | ns   |
| t <sub>r</sub>          | rise time                        |                                                                                                                                                  | -    | 4.5   | -    | ns   |
| t <sub>d(off)</sub>     | turn-off delay time              |                                                                                                                                                  | -    | 45    | -    | ns   |
| t <sub>f</sub>          | fall time                        |                                                                                                                                                  | -    | 20    | -    | ns   |
| g <sub>fs</sub>         | transfer conductance             | V <sub>DS</sub> = -13 V; I <sub>D</sub> = -1 A; T <sub>j</sub> = 25 °C                                                                           | 1.5  | 4.5   | -    | S    |
| Source-drain diode      |                                  |                                                                                                                                                  |      |       |      |      |
| V <sub>SD</sub>         | source-drain voltage             | I <sub>S</sub> = -0.62 A; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C                                                                          | -    | -0.62 | -1.3 | V    |
| t <sub>rr</sub>         | reverse recovery time            | I <sub>S</sub> = -0.5 A; dI <sub>S</sub> /dt = -100 A/μs; V <sub>GS</sub> = 0 V; V <sub>DS</sub> = -12.8 V; T <sub>j</sub> = 25 °C               | -    | 75    | -    | ns   |
| Q <sub>r</sub>          | recovered charge                 |                                                                                                                                                  | -    | 69    | -    | nC   |



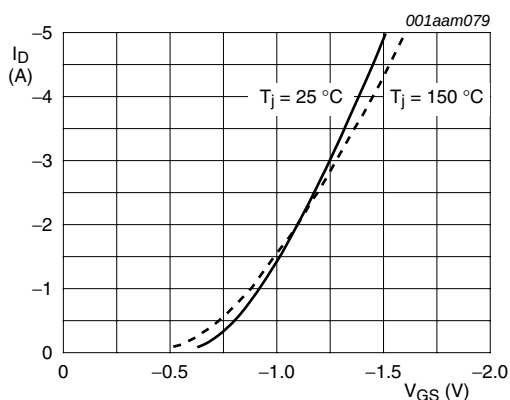
$T_j = 25^\circ\text{C}$

**Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values**



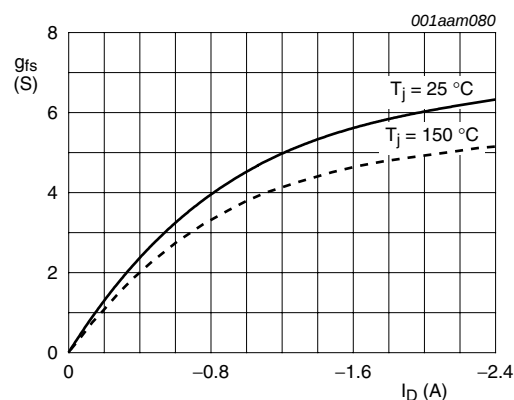
$T_j = 25^\circ\text{C}$

**Fig 6. Drain-source on-state resistance as a function of drain current; typical values**



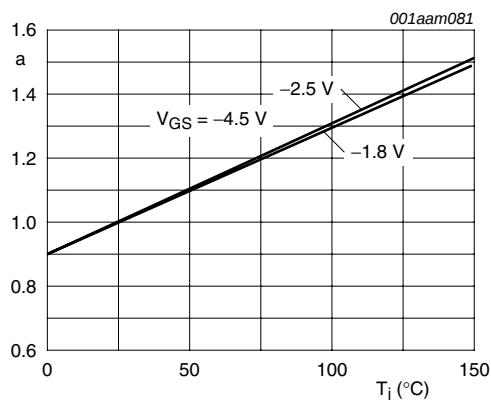
$V_{DS} > I_D \times R_{DSon}$

**Fig 7. Transfer characteristics: drain current as a function of gate-source voltage; typical values**



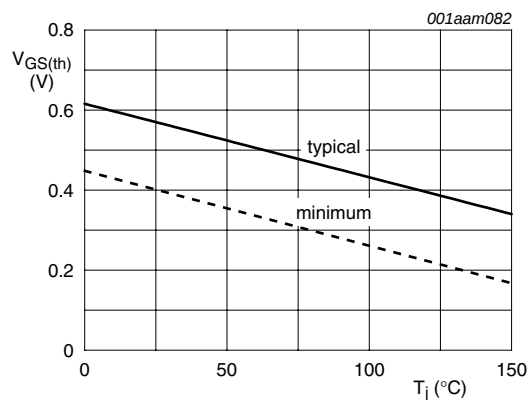
$V_{DS} > I_D \times R_{DSon}$

**Fig 8. Forward transconductance as a function of drain current; typical values**



$$a = \frac{R_{DSon}}{R_{DSon(25^\circ\text{C})}}$$

**Fig 9. Normalized drain-source on-state resistance factor as a function of junction temperature**



$I_D = 1\text{ mA}; V_{DS} = V_{GS}$

**Fig 10. Gate-source threshold voltage as a function of junction temperature**

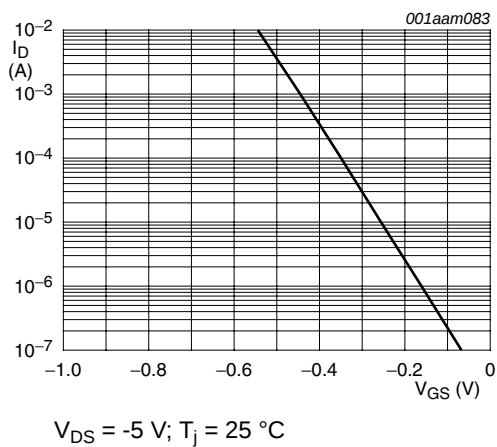


Fig 11. Sub-threshold drain current as a function of gate-source voltage

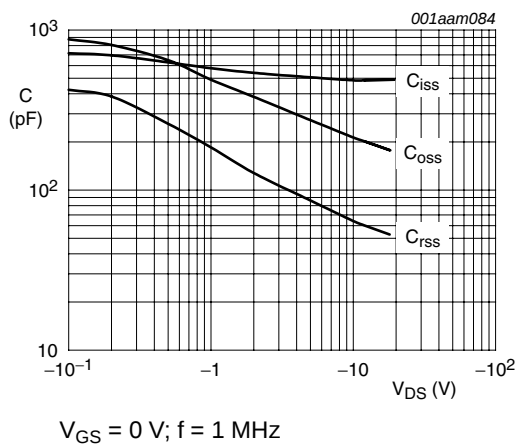


Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

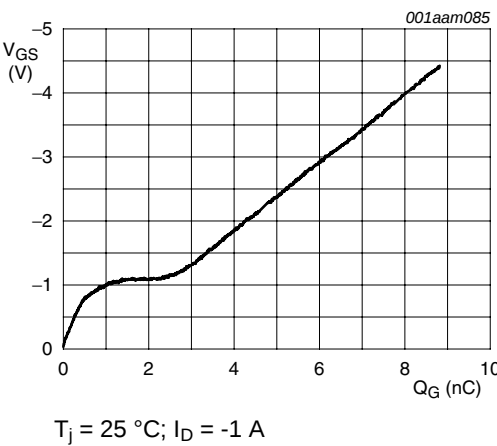


Fig 13. Gate-source voltage as a function of turn-on gate charge; typical values

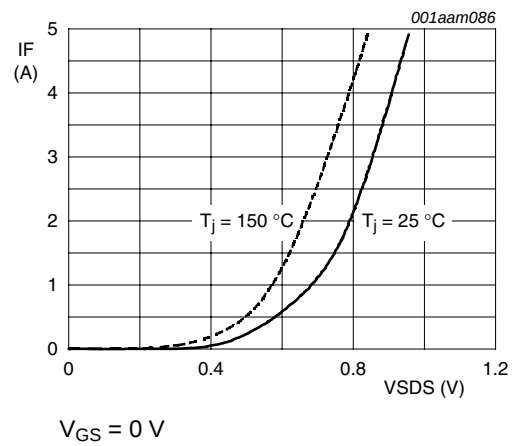


Fig 14. Reverse diode current as a function of reverse diode voltage; typical values

7. Package outline

SO8: plastic small outline package; 8 leads; body width 3.9 mm SOT96-1

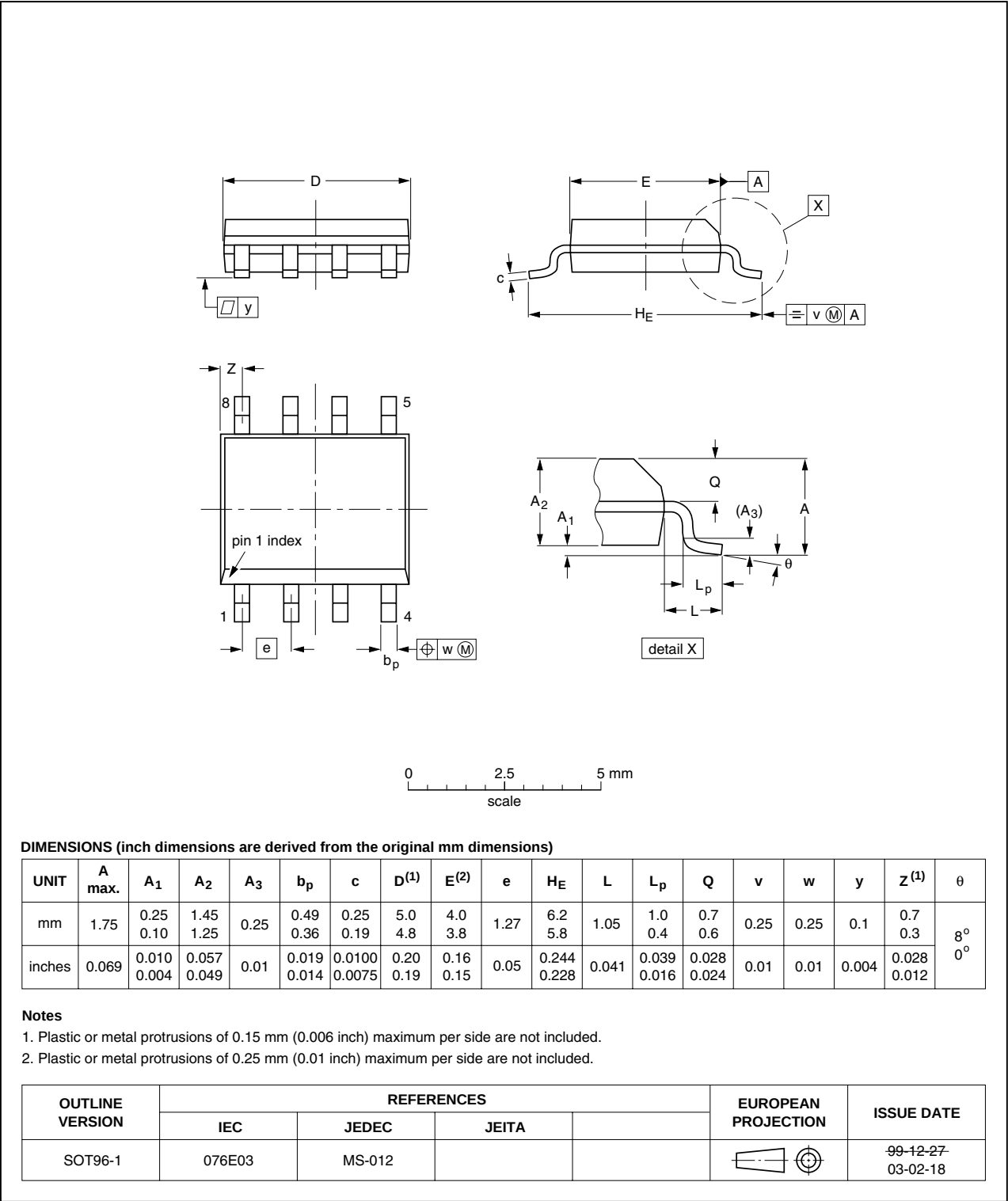


Fig 15. Package outline SOT96-1 (SO8)

## 8. Revision history

Table 7. Revision history

| Document ID    | Release date                                                                                                                                                                                                                                             | Data sheet status     | Change notice | Supersedes    |
|----------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----------------------|---------------|---------------|
| PHK04P02T v.2  | 20101214                                                                                                                                                                                                                                                 | Product data sheet    | -             | PHK04P02T v.1 |
| Modifications: | <ul style="list-style-type: none"><li>• The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li><li>• Legal texts have been adapted to the new company name where appropriate.</li></ul> |                       |               |               |
| PHK04P02T v.1  | 20020501                                                                                                                                                                                                                                                 | Product specification | -             | -             |

## 9. Legal information

### 9.1 Data sheet status

| Document status <sup>[1][2]</sup> | Product status <sup>[3]</sup> | Definition                                                                            |
|-----------------------------------|-------------------------------|---------------------------------------------------------------------------------------|
| Objective [short] data sheet      | Development                   | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet    | Qualification                 | This document contains data from the preliminary specification.                       |
| Product [short] data sheet        | Production                    | This document contains the product specification.                                     |

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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